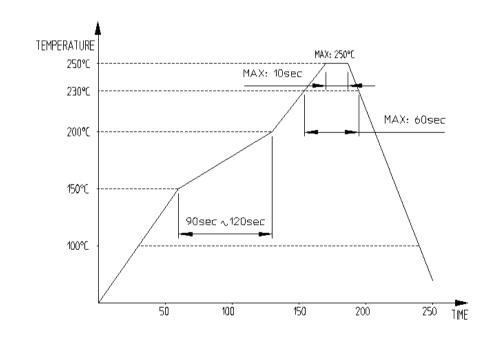
REV	V COUNT DESCRIPTION OF REVIS			ISIONS	BY	CHKD	DATE	REV	COUNT	DES	CRIPTION OF REV	ISIONS	BY	CHKD	DA	ΤE
<u> </u>	- Revised				BJH	LHJ	18.03.16	3	-	Revis	ised KYG			LHJ	21.0	8.23
<u>/2\</u>	2 - Revised				HMY LHJ 18.04.09 4 - Revised KYI							LHJ	21.1	2.16		
					Universal Serial Bus Type-C Cable and Connector Specification Release 2.1 Universal Serial Bus Type-C Connectors and Cable Assemblies Compliance Document Revision 2.1b											
RATING CURRENT					1.25A Max. for each power pin (A1, A4, A9, A12, B1, B4, B5, B9, B12) 0.25A for the other pins											
VOLTAGE					48V AC/DC											
OPERATING CONDITION STORAGE CONDITION					-40℃ ~ +105℃ (INCLUDING TEMP. RISE), 95% RH max. (NON-CONDENSING) -10℃ ~ +60℃ (WITH PACKING), 15% ~ 70% RH											
Para.	ara. Test Description				Test Procedure						Test Requirement					ΑT
1	1 Examination of product				EIA 364-18 Visual inspection					١	No physical damage.					0
Elect	rical Re	quire	ments													
2	2 Low Level Contact Resistance			Measur at 100n 4-wire the resi	EIA 364-23 Measure at 20mV max open circuit at 100mA (DC OR 1000Hz). 4-wire measurement is required and the resistance of PCB termination shall be deducted from the reading.					1	Initial: 40mΩ max for each contact After test: 50mΩ max for each contact					ı
3	Dielectric Withstanding Voltage				EIA 364-20 Measure per Method B with unmated condition. 100V AC RMS for 1 minute at sea level.					N	No disruptive discharge.					1
4	Insulation Resistance				EIA 364-21 500V DC with unmated and mated condition.					1	100MΩ min.					
Mech	nanical	Requi	rements													
5	5 Insertion force				I−13 e at 12.	5mm/mi	nute mir	١.			Initial & after test: 5N ~ 20N (with virgin plug)					-
6	E	xtracti	on force		EIA 364-13 Measure at 12.5mm/minute min.						Initial: 8N ~ 20N After test: 6N ~ 20N (with virgin plug)					_
7	7 Durability M				EIA 364-09 Mated 10,000 times Mechanically operated: 500cycles/hr Mating stroke: 2.75mm Insertion, extraction force shall be measured at a maximum speed of 12.5mm/min				N	No physical damage.				0	1	
8		Air-	Leak	Input ai	r pressu	ure: 20±5% KPa for 5sec.					Inspection leakage: 0.3% (60Pa) max.					-
9		IP:	X8			e water 1.5m fo	r 30min.			N	No water penetration.					-
10	Ra	andom	Vibration	EIA 364-28 Test Condition VII, Test Letter D					0	No physical damage. No discontinuity of 1us of longer duration when mated connector during test.						
REMAR	REMARKS				DRA	\FT	DES	SIGN	CHECK	APPROVAL RE		REL	ELEASE			
					S.H.	LIM	S.H	I.LIM	H.J.LEE	EE		DE 21.1		6		
					18.0	2.19	18.0	2.19		18.02.19 18.02.19 ENG						
NOTE)	NOTE) QT : QUALIFICATION TEST, AT : ASSURANCE TEST, O						: Applic	able Te	st							
DWG NO CL NO CL NO CL NO				PART NO CX90MWD2-			-24P									
				1					1							
HIS HIROSE KOREA.CO.,LTD				PRODUCT SPECIFICATION //3								3				

Para.	Test Description	Test Procedure	Test Requirement	QT	ΑТ				
Environmental Requirements									
11	Temperature Life	EIA 364-17, Method A 105℃ without applied voltage for 120hours.	No physical damage.	o	_				
12	Cyclic Temperature and Humidity	EIA 364-31 25±3°C at 80±3% RH for 1hour. 65±3°C at 50±3% RH for 1hour. Thermal ramp: 0.5hour Number of cycles: 24cycles	No physical damage.	0	ı				
13	Thermal Shock	EIA 364-32, Test Condition I 10cycles -55°C and +105°C	No physical damage.	0	-				
14	Solderability	EIA 364-52 Dwell in 245±5℃ of the solder bath for 5sec.	Solder coverage shall be 95% min. of the immersed surfaces.	0	ı				
15	Salt Spray	EIA 364-26 5% of NaCl in 35℃ for 48hours.	No corrosions that affect to the connector operation.	0	ı				
16	Reflow test	Reflow profile [Fig.1] Peak 250°C max for 10sec 2times.	Co-planarity Before & after Reflow 0.08 max. No deformation of mold No shape of blister and popcorn	0					

REMARKS



[Fig.1] REFLOW TEMPERATURE

NOTE) QT: QUALIFICATION TEST, AT: ASSURANCE TEST, O: Applicable Test									
DWG NO	CL NO	PART NO							
ELC4-632534	CL 6240-0016-6	CX90MWD2-24P							

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PRODUCT SPECIFICATION

Qualification Test Sequence Table											
Para.	Test Description		В	С	D	Е	F	G	Н	I	J
1	Examination of Product		1	1	1	1	1	1	1	1	1
2	Low Level Contact Resistance			2,4	2,10	2,4	2,4	2,4		2,4	
3	Dielectric Withstanding Voltage				3,11						
4	Insulation Resistance				4,12						
5	Insertion Force				5,8						
6	Extraction Force				6,9						
7	Durability				7						
8	Air-leak	2									
9	IPX8		2								
10	Random Vibration			3							
11	Temperature Life					3					
12	Cyclic Temperature and Humidity						3				
13	Thermal Shock							3			
14	Solderability								2		
15	Salt Spray									3	
16	Reflow Test										2

Remarks

NOTE) QT : QUALIFICATION TEST, AT : ASSURANCE TEST, O : Applicable Test

DWG NO

ELC4-632534

CL NO

PART NO

CX90MWD2-24P

HIS HIROSE KOREA.CO.,LTD

PRODUCT SPECIFICATION

¹⁾ Numbers in the table above indicate the sequence corresponding to each test group.